CLAIMS

What is claimed is:

1. A phase-locked loop (PLL) for producing sampling points for high-speed serial data, comprising:

a clock and data recovery (CDR) module coupled to receive the high-speed serial data, the CDR module producing phase information;

a charge pump for producing an error current that reflects a phase difference between a feedback signal and a phase of the high-speed serial data based on the phase information;

a loop filter coupled to receive the error current, wherein the loop filter converts the error current to a voltage signal;

a voltage controlled oscillator (VCO) coupled to receive the voltage signal, wherein the VCO produces a local oscillation that corresponds to the voltage signal and further wherein the local oscillation is produced to the CDR module as the feedback signal; and

wherein the charge pump further includes adjustment circuitry for selectively adjusting the error current to cause the feedback signal to be phase adjusted to any desired point within a period of each bit of the high-speed serial data.

2. The PLL of claim 1 wherein the adjustment circuitry comprises an adjustable current source coupled to selectively sink current from a positive current summing point and a negative current summing point of the charge pump.

- 3. The PLL of claim 2 wherein the adjustable current source further includes a reference current device and a plurality of mirror devices coupled in a current mirror configuration wherein the plurality of mirror devices are scaled in length and width to conduct specified current levels relative to the reference current device.
- 4. The PLL of claim 2 wherein the charge pump further comprises a plurality of current sources formed to supply current based on a bias voltage and an adjustable resistor,
- 5. The PLL of claim 4 wherein the adjustable resistor comprises a plurality of resistors coupled in parallel wherein at least two of the plurality of resistors are selectively coupled in parallel.
- 6. The PLL of claim 4 wherein at least one of the plurality of resistors consists of a MOSFET transistor configured to operate in a linear range as a resistor.
- 7. The PLL of claim 4 wherein at least one of the plurality of resistors consists of resistive elements coupled in series with selectively operated switches.
- 8. The PLL of claim 4 wherein the charge pump further comprises a common mode feedback block coupled at an

output of the charge pump for removing a common mode current level from the error current.

- 9. The PLL of claim 1 wherein the charge pump further includes at least one current source for selectively adding current to the error current and further includes at least one current sink for selectively subtracting current from the error current.
- 10. The PLL of claim 8 wherein the current sink includes at least one adjustable current source coupled between a current summing point and circuit common.
- 11. The PLL of claim 9 wherein the adjustment circuitry further includes at least two adjustable current sinks coupled between positive and negative current summing points and circuit common wherein each is coupled in parallel to a corresponding current sink that sink and source current responsive to at least one of transition and phase information.
- 12. The PLL of claim 10 wherein the adjustment circuitry further includes a current control module for providing control signals to control an amount of current sinked by the at least two adjustable current sinks.
- 13. A phase detection module for adjusting a sampling point of serial data, the phase detection module comprising:
- a leading edge detector coupled to receive the serial data, the leading edge detector producing an error signal

reflecting a difference between the serial data and a received feedback signal;

a charge pump for producing an error current to a loop filter, the error current magnitude corresponding to the reflected difference between the serial data leading edge detector and the received feedback signal; and

adjustment circuitry for selectively sinking current from the error current to cause the sampling point to shift.

- 14. The phase detection module of claim 12, wherein the sampling point is generated by an oscillator that produces oscillations that correspond to the error current.
- 15. The phase detection module of claim 12, wherein the adjustment circuitry further includes:

an adjustable current sink for sinking current from the error current; and

- a current control module for selectively adjusting current levels from the adjustable current sink.
- 16. The phase detection module of claim 14 wherein the adjustable current sink further includes a first plurality of current mirror devices scaled in length and width to source current proportional to a first current mirror reference device.
- 17. The phase detection module of claim 15 wherein the adjustable current sink further includes a second

plurality of current mirror devices scaled in length and width to sink current proportional to a second current mirror reference device.

18. A method for adjusting a sampling point of high-speed serial data, the method comprising:

receiving high-speed serial data in a clock and data recovery (CDR) module and producing therefrom an error signal based on the received high-speed serial data;

producing an error current from a charge pump responsive to the received error signal;

adjusting the error current to selectively position the sampling point to any desired point within a bit period of the received high-speed serial data;

coupling the error current to a loop filter to produce therefrom a control voltage proportional to the error current;

coupling the control voltage to a voltage controlled oscillator wherein the control voltage adjusts a frequency of a local oscillation signal; and

coupling the adjusted local oscillation signal as a feedback signal to the CDR module wherein the feedback signal adjusts the sampling point of the high-speed serial data.

19. The method of claim 17 wherein the error signal includes at least one of phase information and transition information.

- 20. The method of claim 17 wherein the step of adjusting the error current further includes selectively coupling at least one of a plurality of current mirror devices to a current summing point.
- 21. The method of claim 19 wherein the plurality of current mirror devices are scaled in length and width to produce current relative to at least one reference device.